

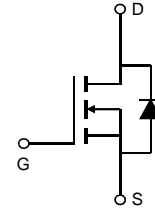
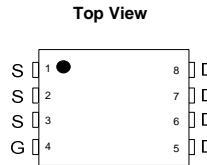
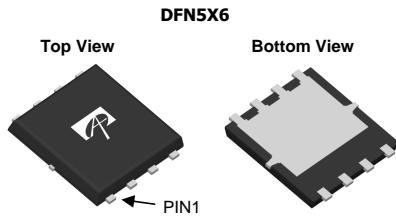
### General Description

The AON6414A uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge. This device is suitable for use as a high side switch in SMPS and general purpose applications.

### Product Summary

|                                  |                  |
|----------------------------------|------------------|
| $V_{DS}$                         | 30V              |
| $I_D$ (at $V_{GS}=10V$ )         | 30A              |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ )  | < 8m $\Omega$    |
| $R_{DS(ON)}$ (at $V_{GS}=4.5V$ ) | < 10.5m $\Omega$ |

100% UIS Tested  
 100%  $R_g$  Tested



### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter                              | Symbol           | Maximum                  | Units            |
|--|------------------|--------------------------|------------------|
| Drain-Source Voltage                   | $V_{DS}$         | 30                       | V                |
| Gate-Source Voltage                    | $V_{GS}$         | $\pm 20$                 | V                |
| Continuous Drain Current               | $I_D$            | $T_C=25^\circ\text{C}^G$ | 30               |
|  |                  | $T_C=25^\circ\text{C}^I$ | 50               |
|  |                  | $T_C=100^\circ\text{C}$  | 30               |
| Pulsed Drain Current <sup>C</sup>      | $I_{DM}$         | 140                      | A                |
| Continuous Drain Current               | $I_{DSM}$        | $T_A=25^\circ\text{C}$   | 13               |
|  |                  | $T_A=70^\circ\text{C}$   | 10               |
| Avalanche Current <sup>C</sup>         | $I_{AS}, I_{AR}$ | 35                       | A                |
| Avalanche energy $L=0.05\text{mH}^C$   | $E_{AS}, E_{AR}$ | 31                       | mJ               |
| $V_{DS}$ Spike                         | 100ns            | $V_{SPIKE}$              | 36               |
| Power Dissipation <sup>B</sup>         | $P_D$            | $T_C=25^\circ\text{C}$   | 31               |
|  |                  | $T_C=100^\circ\text{C}$  | 12.5             |
| Power Dissipation <sup>A</sup>         | $P_{DSM}$        | $T_A=25^\circ\text{C}$   | 2.3              |
|  |                  | $T_A=70^\circ\text{C}$   | 1.5              |
| Junction and Storage Temperature Range | $T_J, T_{STG}$   | -55 to 150               | $^\circ\text{C}$ |

### Thermal Characteristics

| Parameter                                  | Symbol          | Typ | Max | Units                     |
|--|-----------------|-----|-----|---------------------------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 17  | 21  | $^\circ\text{C}/\text{W}$ |
| Maximum Junction-to-Ambient <sup>A D</sup> |                 |     |     |                           |
| Maximum Junction-to-Case                   | $R_{\theta JC}$ | 3.4 | 4   | $^\circ\text{C}/\text{W}$ |

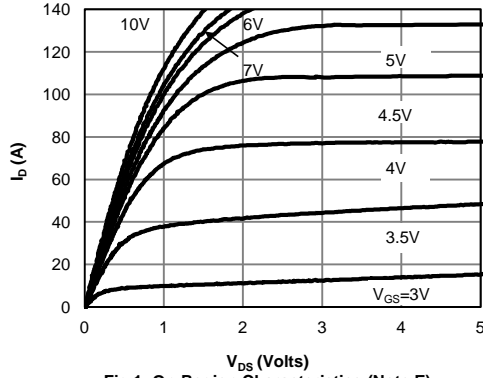
**Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions  | Min  | Typ        | Max       | Units            |
|-----------------------------|---------------------------------------|---|--|------------|-----------|------------------|
| <b>STATIC PARAMETERS</b>    |                                       |   |  |            |           |                  |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage        | $I_D=250\mu\text{A}$ , $V_{GS}=0\text{V}$   | 30   |            |           | V                |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | $V_{DS}=30\text{V}$ , $V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$                  |  |            | 1<br>5    | $\mu\text{A}$    |
| $I_{GSS}$                   | Gate-Body leakage current             | $V_{DS}=0\text{V}$ , $V_{GS}=\pm 20\text{V}$  |  |            | 100       | nA               |
| $V_{GS(th)}$                | Gate Threshold Voltage                | $V_{DS}=V_{GS}$ , $I_D=250\mu\text{A}$  | 1.5  | 1.95       | 2.5       | V                |
| $I_{D(ON)}$                 | On state drain current                | $V_{GS}=10\text{V}$ , $V_{DS}=5\text{V}$  | 140  |            |           | A                |
| $R_{DS(ON)}$                | Static Drain-Source On-Resistance     | $V_{GS}=10\text{V}$ , $I_D=20\text{A}$<br>$T_J=125^\circ\text{C}$                   |  | 6.6<br>9.5 | 8<br>11.4 | $\text{m}\Omega$ |
|                             |                                       | $V_{GS}=4.5\text{V}$ , $I_D=20\text{A}$   |  | 8.2        | 10.5      | $\text{m}\Omega$ |
| $g_{FS}$                    | Forward Transconductance              | $V_{DS}=5\text{V}$ , $I_D=20\text{A}$   |  | 55         |           | S                |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=1\text{A}$ , $V_{GS}=0\text{V}$  |  | 0.72       | 1         | V                |
| $I_S$                       | Maximum Body-Diode Continuous Current |   |  |            | 35        | A                |
| <b>DYNAMIC PARAMETERS</b>   |                                       |   |  |            |           |                  |
| $C_{iss}$                   | Input Capacitance                     | $V_{GS}=0\text{V}$ , $V_{DS}=15\text{V}$ , $f=1\text{MHz}$                          | 920  | 1150       | 1380      | pF               |
| $C_{oss}$                   | Output Capacitance                    |   | 125  | 180        | 235       | pF               |
| $C_{rss}$                   | Reverse Transfer Capacitance          |   | 60   | 105        | 150       | pF               |
| $R_g$                       | Gate resistance                       | $V_{GS}=0\text{V}$ , $V_{DS}=0\text{V}$ , $f=1\text{MHz}$                           | 0.55   | 1.1        | 1.65      | $\Omega$         |
| <b>SWITCHING PARAMETERS</b> |                                       |   |  |            |           |                  |
| $Q_g(10\text{V})$           | Total Gate Charge                     | $V_{GS}=10\text{V}$ , $V_{DS}=15\text{V}$ , $I_D=20\text{A}$                        | 16   | 20         | 24        | nC               |
| $Q_g(4.5\text{V})$          | Total Gate Charge                     |   | 7.6  | 9.5        | 11.4      | nC               |
| $Q_{gs}$                    | Gate Source Charge                    |   | 2  | 2.7        | 3.2       | nC               |
| $Q_{gd}$                    | Gate Drain Charge                     |   | 3  | 5          | 7         | nC               |
| $t_{D(on)}$                 | Turn-On DelayTime                     | $V_{GS}=10\text{V}$ , $V_{DS}=15\text{V}$ , $R_L=0.75\Omega$ ,<br>$R_{GEN}=3\Omega$ |  | 6.5        |           | ns               |
| $t_r$                       | Turn-On Rise Time                     |   |  | 2          |           | ns               |
| $t_{D(off)}$                | Turn-Off DelayTime                    |   |  | 17         |           | ns               |
| $t_f$                       | Turn-Off Fall Time                    |   |  | 3.5        |           | ns               |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      |   | $I_F=20\text{A}$ , $dI/dt=500\text{A}/\mu\text{s}$ | 7          | 8.7       | 10.5             |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=20\text{A}$ , $dI/dt=500\text{A}/\mu\text{s}$                                  | 11   | 13.5       | 16        | nC               |

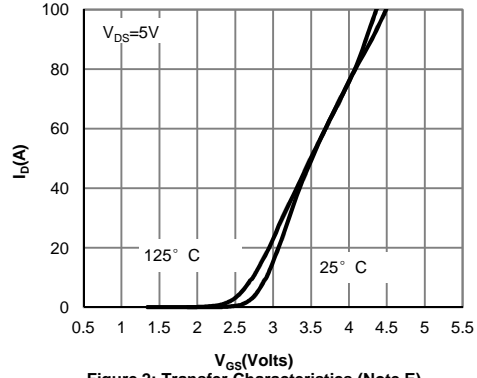
- A. The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The Power dissipation  $P_{DSM}$  is based on  $R_{\theta JA}$  and the maximum allowed junction temperature of  $150^\circ\text{C}$ . The value in any given application depends on the user's specific board design.
- B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- C. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}=150^\circ\text{C}$ . Ratings are based on low frequency and duty cycles to keep initial  $T_J=25^\circ\text{C}$ .
- D. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using  $<300\mu\text{s}$  pulses, duty cycle 0.5% max.
- F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}=150^\circ\text{C}$ . The SOA curve provides a single pulse rating.
- G. The maximum current rating is limited by package.
- H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ .
- I. The maximum current rating is limited by silicon

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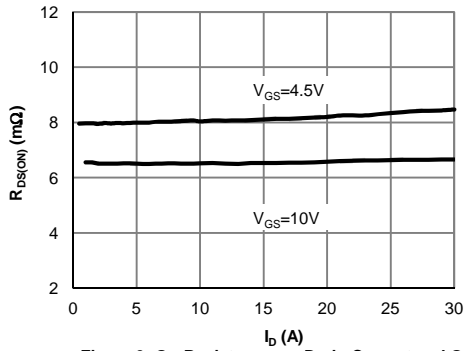
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



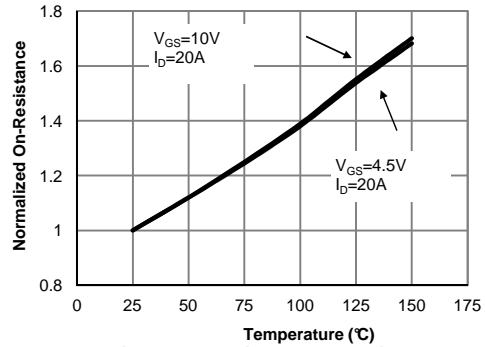
**Figure 1: On-Region Characteristics (Note E)**



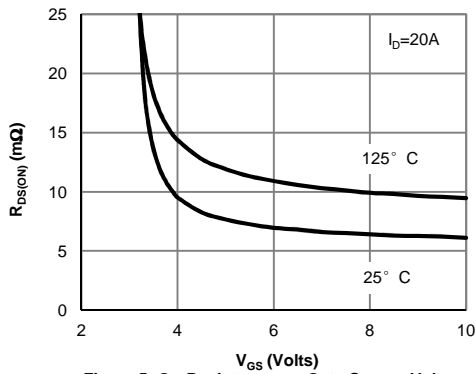
**Figure 2: Transfer Characteristics (Note E)**



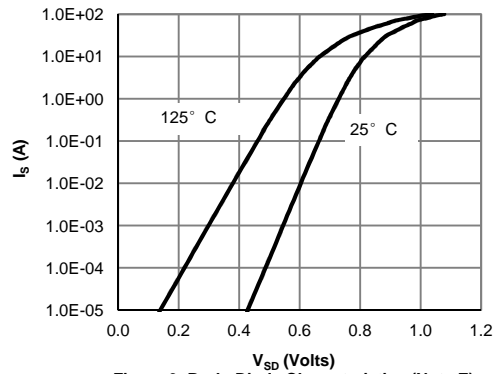
**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**



**Figure 4: On-Resistance vs. Junction Temperature (Note E)**



**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**



**Figure 6: Body-Diode Characteristics (Note E)**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

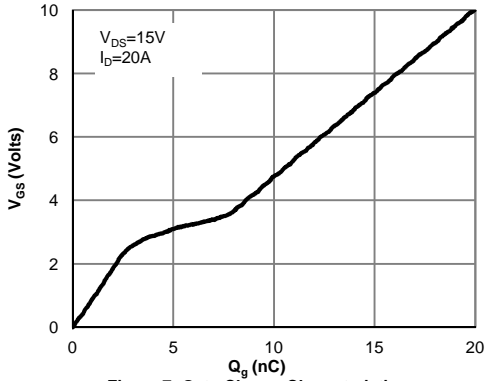


Figure 7: Gate-Charge Characteristics

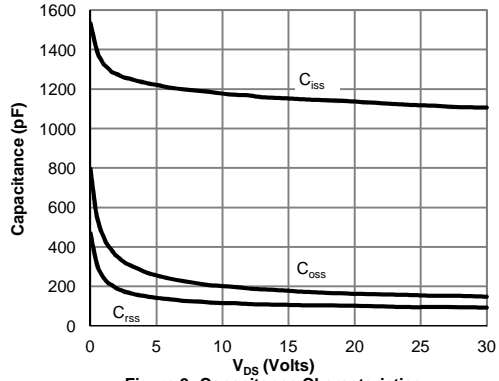


Figure 8: Capacitance Characteristics

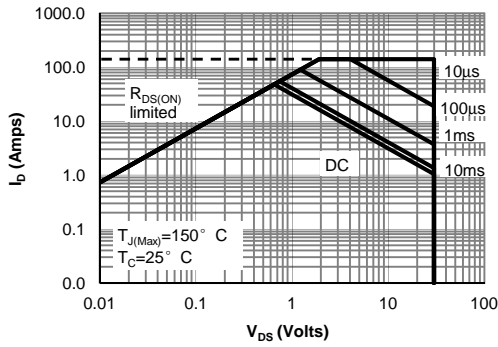


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

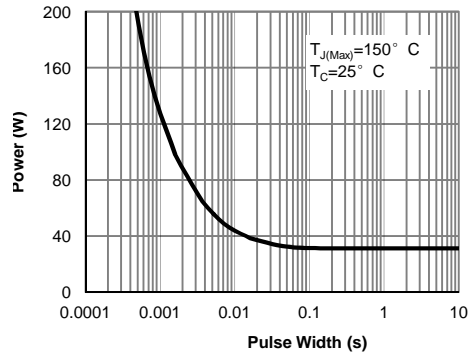


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

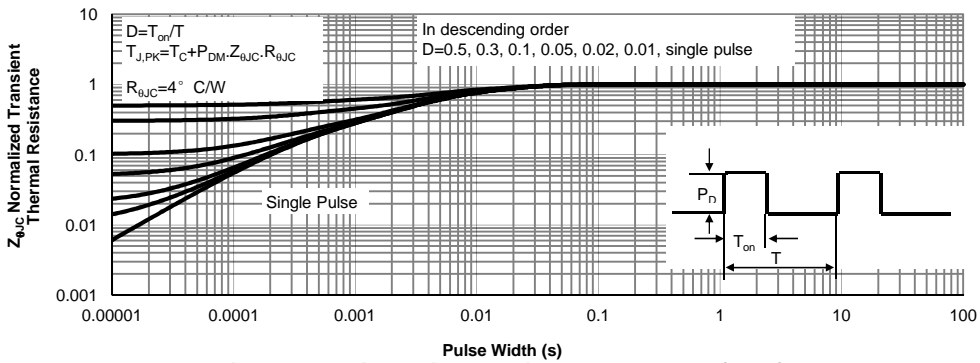
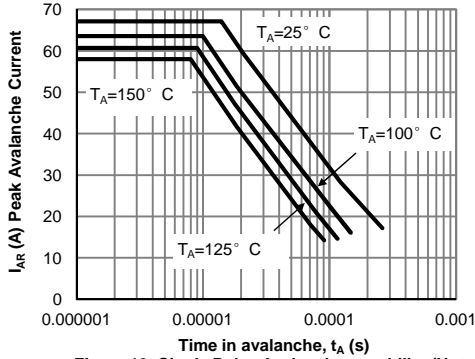
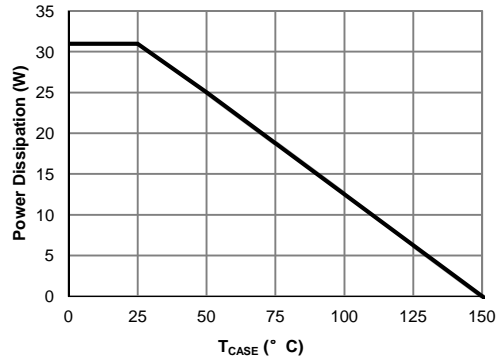


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

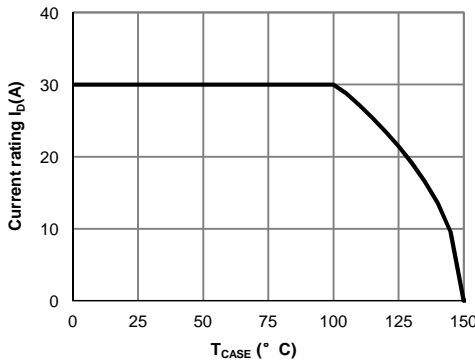
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



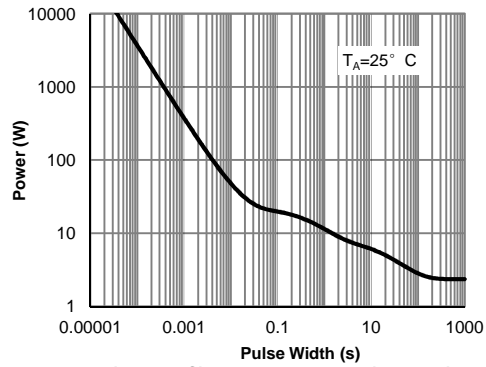
**Figure 12: Single Pulse Avalanche capability (Note C)**



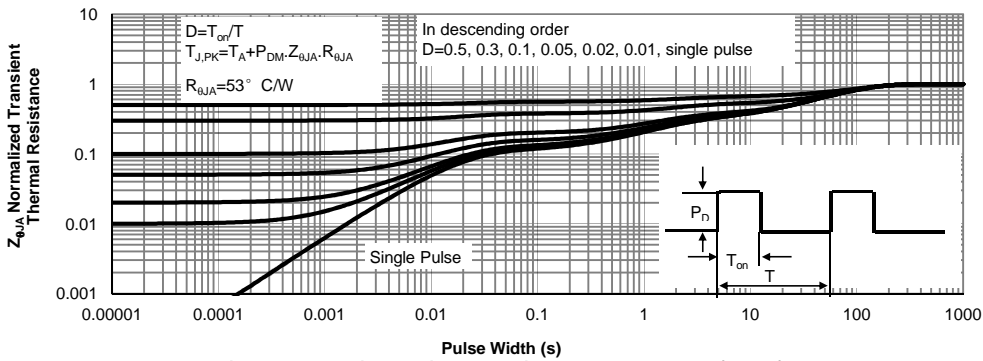
**Figure 13: Power De-rating (Note F)**



**Figure 14: Current De-rating (Note F)**

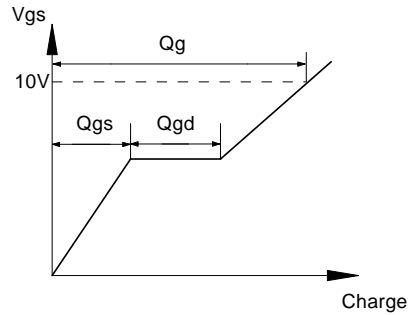
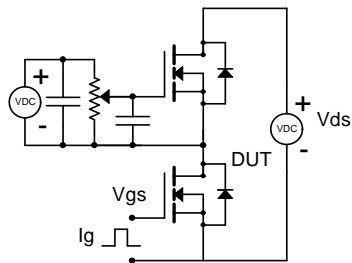


**Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)**

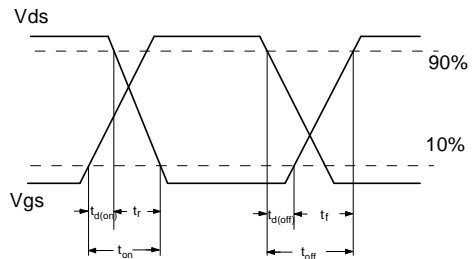
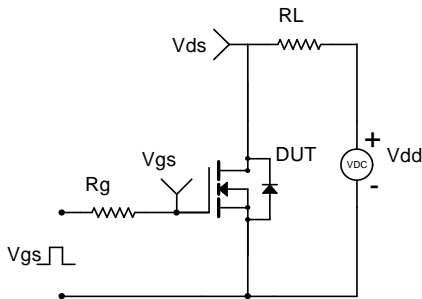


**Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)**

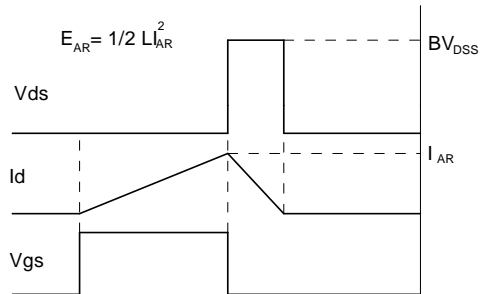
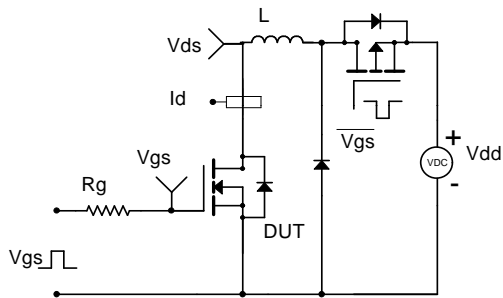
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

